








<b>LIST OF CITATIONS BY APPLICANT</b> Use several sheets if necessary)		Atty. Docket No. 1688A1	Serial No. 09/923,655
		Applicant <u>Diep Nguyen et al.</u>	
		Filing Date August 7, 2001	Group <del>1762</del> 174




## U.S. PATENT DOCUMENTS

#2


Ex. & Trademark Office Init.	Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
	AA	6,255,398	07/03/2001	Zupancic et al.	525	199
	AB	6,017,639	01/25/2000	Higginbotham et al.	428	458
	AC	4,659,768	04/21/1987	Tortorello et al.	524	512
	AD	4,314,004	02/02/1982	Stoneberg	428	421
	AE	3,524,906	08/18/1970	Schmitt et al.	<del>260</del>	<del>900</del>
	AF	3,470,014	09/30/1969	Koblitz et al.	<del>117</del>	<del>72</del>
	AG	3,449,446	06/10/1969	Higgins	<del>260</del>	<del>643</del>
	AH					
	AI					
	AJ					
	AK					
	AL					


RECEIVED  
 JAN 22 2002  
 TC 1700

## FOREIGN PATENT DOCUMENTS

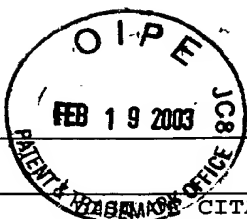
	Document No.	Date	Country	Class	Subclass	Translation Yes	No
	AM	0 960 918	12/01/1999	Europe			
	AN	98/17723	04/30/1998	WIPO			
	AO	756,165	04/04/1967	Canada			
	AP						
	AR						
	AS						

## OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AT	Lin et al., "Fluoropolymer Alloys - Performance Optimization of PVDF Alloys,"
	AU	Fluoropolymers 2: Properties, pp. 121-136, (1999).
	AV	

Examiner 	Date Considered 4-03
--	----------------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



CITATIONS BY APPLICANT (Use several sheets if necessary)	Atty. Docket No. 1688A1	Serial No. 09/923,655
	Applicant Diep Nguyen et al.	
	Filing Date August 7, 2001	Group <del>1762</del> 1711

## U.S. PATENT DOCUMENTS

#3

Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
<i>m</i>	AA	4,786,546	11/22/88	Vassiliou	428	215	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

RECEIVED  
FEB 25 2003  
MAIL ROOM

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

AR	JP6-051479, English Language Abstract
AS	JP01-070108, English Language Abstract
AT	

FOREIGN DOCUMENTS  
IMPROPER

Examiner	<i>Walt M. Wirth</i>	Date Considered	<i>4-03</i>
----------	----------------------	-----------------	-------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.